Electron Emission Models for Simulation K. L. Jensen



Code 6362, MSTD, NRL, Washington DC

*P*³ WORKSHOP 2021 November 10-12, 2021

We gratefully acknowledge: (NRL), A. Shabaev, M. Osofsky, S. Lambrakos; (USNA) D. Finkenstadt; (Leidos) J. Petillo; (AFRL) J. Riga, D. Shiffler; (ASU) O. Chubenko; (LANL) D. Dimitrov, N. Moody, A. Neukirch, J. Smedley, S. Tretiak



FURTHER INFORMATION

This presentation is drawn from cleared open sources:

- K.L. Jensen, J.L. Lebowitz, J.M. Riga, D.A. Shiffler, and R. Seviour, "Reevaluating the Hartman Effect for Field Emission" (submitted, Sept. 2021)
- K. L. Jensen, A. R. Shabaev, M. Osofsky, "Theory and Modeling of Ultrafast Electron Emission from Nanostructures", NRL Memorandum Report IR-6362-21-34-U, (September 30, 2021)
- K.L. Jensen, J.L. Lebowitz, J.M. Riga, D.A. Shiffler, and R. Seviour, "Wigner wave packets: Transmission, reflection, and tunneling", Phys. Rev. B 103155427 (2021). 10.1103/PhysRevB.103.155427
- K.L. Jensen, A. Shabaev, S.G. Lambrakos, D. Finkenstadt, N.A. Moody, A.J. Neukirch, S. Tretiak, D.A. Shiffler, and J.J. Petillo, "Analytic model of electron transport through and over non-linear barriers", J. Appl. Phys. 127(23), 235301 (2020). 10.1063/5.0009759
- K.L. Jensen, A. Shabaev, S.G. Lambrakos, D. Finkenstadt, J.J. Petillo, A.M. Alexander, J. Smedley, N.A. Moody, H. Yamaguchi, F. Liu, A.J. Neukirch, and S. Tretiak, "An extended moments model of quantum efficiency for metals and semiconductors", J. Appl. Phys. **128**(1), 015301 (2020). 10.1063/5.0011145

Additional Supportive Sources:

- N.A. Moody, K.L. Jensen, A. Shabaev, S.G. Lambrakos, J. Smedley, D. Finkenstadt, J.M. Pietryga, P.M. Anisimov, V. Pavlenko, E.R. Batista, J.W. Lewellen, F. Liu, G. Gupta, A. Mohite, H. Yamaguchi, M.A. Hoffbauer, and I. Robel, "Perspectives on Designer Photocathodes for X-ray Free-Electron Lasers: Influencing Emission Properties with Heterostructures and Nanoengineered Electronic States", Physical Review Applied 10(4), 047002 (2018). PhysRevApplied.10.047002
- Jensen2019b K.L. Jensen, M. McDonald, O. Chubenko, J.R. Harris, D.A. Shiffler, N.A. Moody, J.J. Petillo, and A.J. Jensen, "Thermal-field and photoemission from meso- and micro-scale features: Effects of screening and roughness on characterization and simulation", J. Appl. Phys. **125(23)**, 234303 / 1-25 (2019). 10.1063/1.5097149
- K.L. Jensen, M. McDonald, J.R. Harris, D.A. Shiffler, M. Cahay, and J.J. Petillo, "Analytic model of a compound thermal-field emitter and its performance", J. Appl. Phys. 126(24), 245301 (2019). 10.1063/1.5132561
- K.L. Jensen, "A reformulated general thermal-field emission equation", J. Appl. Phys. 126(6), 065302 / 1-13 (2019). 10.1063/1.5109676
- K.L. Jensen, D. Finkenstadt, D.A. Shiffler, A. Shabaev, S.G. Lambrakos, N.A. Moody, and J.J. Petillo, "Analytical Models of Transmission Probabilities for Electron Sources", J. Appl. Phys. **123(6)**, 065301 (2018). doi.org/10.1063/1.5018602

Enabling Particle-in-Cell Simulations Three-Step Framework Absorption-Reflection: Dielectric Parameters

SPEED Canonical emission equations Analytic Methods Smooth Surface Isolated Emitter Instantaneous Emission





Buridan's PICass

ACCURACY Space Charge + Curvature Barriers Adaptive Meshing Intrinsic Emittance Shielding Delayed Emission & Transit Times



- Canonical Eqs. (FD, FN, RLD) are fast, but neglect Photo-Thermal-Field & mesoscale; analytical models are exact but actual emitters are complicated; instantaneous emission assumed
- PIC handles Shielding, Space Charge, and Field affected by roughness, but nanoscale primary determinant of all thermal-field-photoemission contributions

Thermal-Field-Photoemission Emission Challenges to Simulation Codes:

Everything affects emission. Emission affects T and surface field. Space charge, *T*, *F* affects Everything



Enabling Particle-in-Cell Simulations Three-Step Framework Absorption-Reflection: Dielectric Parameters

ABSORPTION-TRANSPORT-EMISSION MODEL

$$QE = [1 - R(\omega)] \frac{\int_{E_a}^{h\omega - E_g} EdE \int_{\sqrt{E_a/E}}^{1} x dx \, D_{\Lambda}(Ex^2) f_{\lambda}(x, E)}{2 \int_{0}^{h\omega - E_g} E \left[\int_{0}^{1} dx \right] dE}$$
(1)

High, thin triangular barrier: $s^2 \equiv (\hbar \omega - E_g - E_a)/E_a$ and $C \approx n(1 - R)/(1 + p)$ with n = O(1)

$$D_{\Delta}(E) \approx \frac{4[E(E-E_a)]^{1/2}}{\left(E^{1/2} + (E-E_a)^{1/2}\right)^2} \to QE \approx \frac{2Cs^5}{(1+s^2)(1+\sqrt{1+s^2})(s+\sqrt{1+s^2})}$$
(2)



Cs₃Sb: $E_g = 1.6 \text{ eV}, E_a = 0.4 \text{ eV}, R = 0.2$

See Ref. 6



K₂CsSb: $E_g = 1.2 \text{ eV}, E_a = 0.7 \text{ eV}, R = 0.2$



Enabling Particle-in-Cell Simulations Three-Step Framework Absorption-Reflection: Dielectric Parameters

DRUDE-LORENTZ MODEL

Laser penetration depth δ(ω) and reflectivity R(ω)

$$R(\omega) = \frac{(n-1)^2 + k^2}{(n+1)^2 + k^2}$$

$$\delta(\omega) = \frac{c}{2k\omega}$$
(3)

n and *k* from Bound (Lorentz) $\hat{\varepsilon}_b$ & free (Drude) $\hat{\varepsilon}_f$ components \Rightarrow (f_j , Γ_j , ω_j)

$$\hat{\varepsilon}(\omega) = \varepsilon_0 \left(n^2 - k^2 + 2ink\right)$$
$$\equiv \hat{\varepsilon}_f + \hat{\varepsilon}_b$$
$$\hat{\varepsilon}_f(\omega) = 1 - \frac{f_0 \,\omega_p^2}{\omega(\omega + i \,\Gamma_0)}$$
$$\hat{\varepsilon}_b(\omega) = \sum_{j=1}^n \frac{f_j \,\omega_p^2}{(\omega_j^2 - \omega^2 - i\omega\Gamma_j)}$$
(4)

 Right: Perovskites; metals, Multialkali antimonides = similar results

See Ref. 5





Semi-Analytic Gamow Factor Generalized Emission General Barriers and Shape Factor

THE CANONICAL EQUATIONS

Thermal : Richardson-Laue-Dushman

C. Herring, M. Nichols, Rev. Mod. Phys. 21, 185 (1949).

$$J_{RLD}(T) = A_{RLD}T^2 \exp\left(-\frac{\phi}{k_B T}\right)$$
 (5)



E.L. Murphy, R.H. Good, Phys Rev 102, 1464 (1956).

Secondary : Baroody

E.M. Baroody, Phys. Rev. 78, 780 (1950)

$$\delta(E_o) = BE_o e^{-\lambda} \int_0^1 \exp\left(\lambda s^2\right) ds \quad (8)$$

Space Charge : Child-Langmuir

$$J_{CL}(\varphi_a) = \frac{4\varepsilon_0}{9D^2} \left(\frac{2q}{m}\right)^{1/2} \varphi_a^{3/2} \qquad (9)$$

 $\begin{array}{l} \Phi = \text{Work Function}; \ T = \text{Temperature}; \ F = q \mathcal{E}; \\ \hbar \omega = \text{Photon energy}; \ I_{\omega} = \text{laser intensity}; \\ E_o = \text{Primary electron beam energy}; \\ \lambda = \text{energy loss per unit length} \\ D = \text{anode-cathode gap}; \ \varphi_a = \text{anode potential} \end{array}$

Equations follow from *J* evaluation

$$J_{FN}(F) = \frac{A_{FN}}{t(y)^2} F^2 \exp\left(-v(y)\frac{B_{FN}\Phi^{3/2}}{F}\right)$$
(6)

Photo : Fowler-DuBridge

L.A. DuBridge, Phys. Rev. 43, 0727 (1933).

$$QE \equiv \frac{\hbar\omega}{q} \left(\frac{J}{I_{\omega}}\right) \propto (\hbar\omega - \phi)^2 \qquad (7)$$



Semi-Analytic Gamow Factor Generalized Emission General Barriers and Shape Factor

Shape Factor Method

$\sigma(E)$ and u(E) (related to $\partial_E \theta$) defined by

$$\sigma(E) = \int_{x_{-}}^{x_{+}} \left\{ \frac{U(x) - E}{U_{o} - E} \right\}^{1/2} \frac{dx}{L}$$
(10)

$$u(E) = \int_{x_{-}}^{x_{+}} \left\{ \frac{U_o - E}{U(x) - E} \right\}^{1/2} \frac{dx}{L}$$
(11)

Length/Height scales: $(\phi = \Phi - \sqrt{4QF})$

$$FL(E) = \sqrt{(\mu + \Phi - E)^2 - 4QF}$$

$$\hbar\kappa(E) \equiv \sqrt{2m(\mu + \phi - E)}$$
(12)

Gamow factor using Shape Function

$$\theta(E) = 2 \sigma(E) \kappa(E) L(E)$$
 (13)

$\sigma(E)$ is factor accounting for shape

- rectangular: $\sigma_{\Box} = 1$
- triangular: $\sigma_{\Delta} = 2/3 = 0.6667$
- parabolic: $\sigma_{0} = \pi/4 = 0.7854$

 $\sigma(E) = \text{red} / \text{blue}; \mu = 7 \text{ eV}, \Phi = 2 \text{ eV}, F = 1 \text{ eV/nm}$



- Relation to Fowler-Nordheim Equation $J_{FN}(F, \Phi) = \frac{qm}{2\pi^2\hbar^3} \frac{e^{-2\sigma[y(\mu)]\kappa(\mu)L(\mu)}}{[2u(\mu)\kappa(\mu)L(\mu)]^2}$
- Relation to SN Functions, $y = \sqrt{4QF}/\Phi$

$$\sigma(\mu) = \frac{2v(y)}{3(1-y)\sqrt{1+y}}; \quad u(\mu) = \frac{2t(y)}{\sqrt{1+y}}$$



Semi-Analytic Gamow Factor Generalized Emission General Barriers and Shape Factor

GENERAL CURRENT DENSITY RELATION I

$$J(F,T) = \int dJ(E) = \frac{qm}{2\pi^2 \beta_T \hbar^2} \int_0^\infty h(E) \frac{\ln\{1 + \exp[\beta_T(\mu - E)]\}}{1 + C(E) \exp[\theta(E)]} dE$$
(14)

Gamow and Field E Slope Factor

$$\theta(E) \equiv \frac{4}{3}\kappa(E)L(E)$$

$$= \frac{4\sqrt{2m}}{3\hbar} (V_o - E)^{3/2}$$

$$\beta_F(E) \equiv -\frac{d\theta}{dE}$$

$$= \frac{2\sqrt{2m}}{\hbar F} (V_o - E)^{1/2}$$
(16)

• Linearize (*E_m* is location of maximum):

$$\theta(E) = \theta(E_m) - \frac{\beta_F(E_m)[E_m - E]}{(17)}$$

• Thermal E Slope factor: $\beta_T \equiv 1/k_B T$

Triangular (FN) Barrier: $V_o = \mu + \Phi$



 $\begin{array}{l} V(\mathbf{x}) = V_o - F \mathbf{x} \\ dJ \mbox{ (normalized) for } \mu = 5 \mbox{ eV}, \ \Phi = 2 \mbox{ eV} \\ T = 1000 \mbox{ K for different } F. \\ Symbols \mbox{ are Exact, Lines are linearized } \theta; \\ \mbox{ color areas: integrand of Eq. (14) using Eq. (17).} \end{array}$



Semi-Analytic Gamow Factor Generalized Emission General Barriers and Shape Factor

GENERAL CURRENT DENSITY RELATION II

The reason for replacing $\theta(E)$ by its linear approximation $\theta(E_m) - \beta_F(E_m)(E - E_m)$ is because doing so leads to an analytic General Thermal-Field-Photoemission equation

GTF in linear θ Approximation (h = C = 1) $J(F, T) \approx A_{RLD}T^2N(n, s)$ $n(F, T) \equiv \frac{\beta_T}{\beta_F(E_m)}$ $s(F, T) \equiv \theta(E_m) + \beta_F(E_m)(E_m - E)$ (18)

• N has field, thermal dominated parts

$$N(n,s) \approx e^{-s} n^2 \Sigma\left(\frac{1}{n}\right) + e^{-ns} \Sigma(n)$$

$$\Sigma(x) \approx \frac{1+x^2}{1-x^2} - 0.36 x^2 - \dots$$
(19)

- Σ(x) is singular at x = 1: both T and F components required to cancel it out
- field limit is FN; thermal limit is RLD



Photoemission: (h,C are involved)

$$J_P \propto (\hbar \omega - \phi)^2 + \frac{\pi^2}{3} \left(\beta_T^{-2} + \beta_F^{-2} \right)$$
(20)
$$(n^2 \ll 1, J_P \to J_{FD})$$



Semi-Analytic Gamow Factor Generalized Emission General Barriers and Shape Factor

QUADRATIC AND MIM BARRIERS







Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

REFLECTIONLESS TRANSMISSION

Pöschl-Teller (PT) well (sech² potential) See Ref. 5

$$V_{pl}(x) = -\frac{\hbar^2 v(v+1)}{2ma^2} \operatorname{sech}^2(x/a)$$
(21)

Integer ν , $D(k) \rightarrow 1 = all$ incident e^- for a particular $k = \sqrt{2mE}/\hbar$ are transmitted (yellow)



TMA Analysis gives D(k): x_i points shown

Modify $D_{\triangle}[E(k)]$ (Eq. 2) by k_a and r from fits

$$D(k) \approx \frac{k^r}{\left(k^{2r} + k_a^{2r}\right)^{1/2}}$$
(22)





Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

WAVE PACKET ON DELTA BARRIER

Delta Function Barrier: $V(x) = (\hbar^2 \gamma/2m)\delta(x)$ Wave function

$$\psi_k(x) = \begin{cases} e^{ikx} + r(k)e^{-ikx} & (x < 0) \\ t(k)e^{ikx} & (x > 0) \end{cases}$$
(23)

$$r(k) = -\frac{i\gamma}{2k+i\gamma}; \ t(k) = \frac{2k}{2k+i\gamma}$$
(24)

$$D(k) = |t(k)|^2 = 4k^2/(4k^2 + \gamma^2)$$
 (25)



See Ref. 1: Above: gaussian wave packet hitting δ -barrier Right: $\rho(\mathbf{x}, t)$ as contour plot: Horizontal white line $\mathbf{x} = 0$ Diagonal white lines = ballistic equations $\mathbf{x}_{\pm}(t) = \pm \hbar k_{0} t/m$.

Ballistic model (white diagonals): $x(t) = x_0 \pm \hbar kt/m$





Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

WAVE PACKET ON WIDE RECTANGULAR BARRIER

- $V(x) = (\hbar^2 k_v^2/2m) \Theta(x)\Theta(L_b x)$
- Group (τ_g), tunneling delay (τ_d), and interference delay (τ_i) times:

$$\tau_{d}(k) \equiv \left(\frac{m}{\hbar k}\right) \int_{0}^{L(k)} |\psi_{k}(k)|^{2} dx$$

$$\tau_{i}(k) \equiv -\frac{\hbar}{k} \Im[r(k)] \left(\frac{dk}{dE}\right)$$
(26)

• Hartman effect: as $L_b \rightarrow \infty$, $\tau_g = \tau_d + \tau_i$ independent of $L_b \ (\theta \rightarrow \infty)$

$$\frac{\tau_d(k)}{\tau_o} = \frac{k}{\kappa(k)} \tanh \theta(k)$$

$$\frac{\tau_i(k)}{\tau_o} = \frac{\kappa(k)}{k} \tanh \theta(k)$$
(27)

- $\tau_o = \hbar/V_o = 0.658$ fs for $V_o = 1 \text{ eV}$
- Gamow Factor $\theta(k)$ is

$$\theta(k) = 2L_b \sqrt{k_v^2 - k^2} \equiv 2 \kappa(k) L_b$$
 (28)

Right: dots = Eq. (26); lines = Eq. (27) See Ref. 1





Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

TRANSMISSION AND REFLECTION DELAY (TARD) MODEL I



- (right top) Contour of p(k, t): locations of peaks define $k_r = -13.1140 \text{ nm}^{-1}$ and $k_t = 14.8152 \text{ nm}^{-1}$ (TARD k). Vertical red lines are at $k = \pm k_0 = \pm 13.5546 \text{ nm}^{-1}$ and k = 0.
- (right bottom) Contour of ρ(x, t): two horizontal black lines defined by crossings at (x = 0), separated by = 0.5461 fs. This is the TARD time



See Ref. 3



Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

Rectangular Barrier



Wave Packets incident on rectangular barrier

Gray and blue lines normalized to incident max. For Case (0.2), solid red line normalized to incident max, and dashed red line to max of transmitted (red) portion; in cases (0.4, 0.8, 1.6), red lines all normalized to transmitted max. Green line is free wave packet normalized to its max, evaluated at the same time as "trans"



 $\rho(x, t)$ normalized to max of each *t* slice $L = 2 \text{ nm}, L_b = 4 \text{ nm}, E_o = 1 \text{ eV}, E_o/V_o = 0.9$, wave packet incident on rectangular barrier. Delay associated with reflection evident in how contour lines depart from white ballistic lines.



Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

TRIANGULAR BARRIERS

- Propagating gaussian wave packet
- $\rho(x, t)$ norm to each tslice for triangular (Fowler Nordheim) barrier
- horizontal = time, vertical = position
- $F_o = q|\mathcal{E}|$ as shown
- White curved line for $x > x_o = W/2$, where W = 50 nm, corresponds to $x_b(t)$
- Both reflected and transmitted show TARD
- Color bar and axis labels (*t*/*t_{max}, x/W*) are same as before.





Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

MEAN TRANSVERSE ENERGY FROM ROUGHNESS I

- $F = q|\mathcal{E}|$ is a force: Total force $F^2 = F_x^2 + F_y^2 + F_z^2$ is product of $\beta(x, y, z_s)$ with the background F_o such that $|\vec{F}| = \beta F_o$.
- $\beta(x, y, z_s)$ for surface used to find $|\vec{F}| = \beta F_o$ used in $J_{GTFP}(F, T)$
- $(\beta > 1)$ near apexes of protrusions, $(\beta < 1)$ occurs in valleys between protrusions



See Ref. 2



Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

MEAN TRANSVERSE ENERGY FROM ROUGHNESS II







Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

BEAM EQUATION I





 e^- emitted with \vec{v}_{\perp} rotate about \vec{B} with frequency $\omega_o = qB/m$.

- Cathode boundary: red thick circle. e⁻ orbit: thin multicolored circles (72 shown) See Ref. 2
- Initial \vec{v}_{\perp} Maxwell-Boltzmann distributed, randomly placed at black dots
- (left) Cathode area is large compared to the orbit radii.
- (right) cathode area is comparable to the orbit radii.



Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

BEAM EQUATION II

• Beam radius \equiv RMS average of individual e^- : (x, y) = cathode plane, \hat{z} = beam direction

$$R(t)^{2} = \frac{1}{N} \sum_{j=1}^{N} \left[x_{j}(t)^{2} + y_{j}(t)^{2} \right]$$
(29)

 R(t) oscillates: d/dt → vd/dz = βcd/dz space charge and emittance ε terms added Beam Envelope (β, γ ↔ relativistic factors)

$$\frac{d^2}{dz^2}R + \left(\frac{qB}{2\beta\gamma mc}\right)^2 R - \frac{2I_a}{(\gamma\beta)^3 I_o}\frac{1}{R} - \frac{\varepsilon^2}{R^3} = 0$$
(30)

 Brillouin flow: blue + green + purple= 0. Current density = current over area

$$\frac{I_a}{\pi R^2} = \frac{I_o}{8\pi} \left(\frac{2K_b}{mc^2}\right)^{1/2} \left(\frac{qB}{mc}\right)^2 \left\{1 - \frac{8mK_b\varepsilon^2}{q^2B^2R^4}\right\}$$
(31)
$$J_{becam}\left(\varepsilon\right) = J_{becam}\left(0\right)\left\{1 - \delta\left(\varepsilon\right)\right\}$$



- Symbols: *R*(*t*) defined by Eq. (29) for the orbits of prior slide
- Lines: ad hoc fit: $R_a(t) = R_o - A\cos(6.3\omega_o t)$
- Smaller beam \Leftrightarrow more ε affects $J(\varepsilon)$
- See Ref. 2



Tunneling/Flyover Times Roughness / Transverse Velocity Back to PIC

CONCLUDING REMARKS

Model Components

- Accurate Physics demands compete with PIC speed demands
- Optical Parameter Model: Lorentz-Drude for absorption, scattering
- Barrier Transport Model: Analytic Gamow Shape factor & TMA
- Emission Delay Model: Wave packets via Wigner and Schrodinger
- Roughness models and Intrinsic Emittance
- Effect on Beam Models

Methods

- DFT provides Lorentz-Drude, Barrier parameters, dielectric info
- Emission Studies and TARD: WDF gives unambiguous k_o, suitable for smoothly varying V(x); Schrödinger Eq. gives exact, suitable for abrupt / simple V(x): method of accounting for tunneling/transmission delays in emission is in progress
- Transmission probabilities give launch velocity, current density for PIC